

<b>Notice of References Cited</b>	Application/Control No. 10/557,108		Applicant(s)/Patent Under Reexamination MIZU ET AL.	
	Examiner N. M. Minnifield		Art Unit 1645	Page 2 of 3

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-			
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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